9 B

8

- Generates Either Odd or Even Parity for Nine Data Lines
- Cascadable for n-Bits
- Can Be Used to Upgrade Existing Systems using MSI Parity Circuits
- Typical Data-to-Output Delay of Only 14 ns for 'S280 and 33 ns for 'LS280
- Typical Power Dissipation:

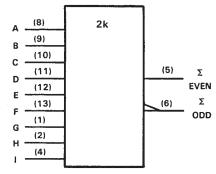
'LS280 . . . 80 mW 'S280 . . . 335 mW

FUNCTION TABLE

NUMBER OF INPUTS A	OUTPUTS					
THRU I THAT ARE HIGH	ΣΕVΕΝ	Σ ODD				
0, 2, 4, 6, 8	Н	L				
1, 3, 5, 7, 9	L	Н				

H = high level, L = low level

logic symbol†



[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

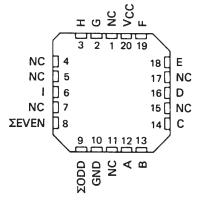
Pin numbers shown are for D, J, N, and W packages.

SN54LS280, SN54S280 . . . J OR W PACKAGE SN74LS280, SN74S280 . . . D OR N PACKAGE (TOP VIEW) G 1 14 14 VCC H 2 13 F NC 3 12 E I 4 11 D ΣΕVEN 5 10 C

SN54LS280, SN54S280 . . . FK PACKAGE (TOP VIEW)

ΣODD ☐6

GND



NC - No internal connection

description

These universal, monolithic, nine-bit parity generators/checkers utilize Schottky-clamped TTL high-performance circuitry and feature odd/even outputs to faciliate operation of either odd or even parity application. The word-length capability is easily expanded by cascading as shown under typical application data.

Series 54LS/74LS and Series 54S/74S parity generators/checkers offer the designer a trade-off between reduced power consumption and high performance. These devices can be used to upgrade the performance of most systems utilizing the '180 parity generator/checker. Although the 'LS280 and 'S280 are implemented without expander inputs, the corresponding function is provided by the availability of an input at pin 4 and the absence of any internal connection at pin 3. This permits the 'LS280 and 'S280 to be substituted for the '180 in existing designs to produce an identical function even if 'LS280's and 'S280's are mixed with existing '180's.

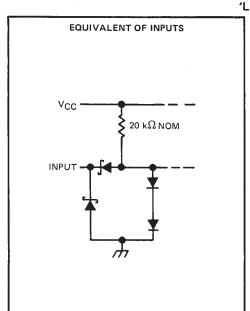
These devices are fully compatible with most other TTL circuits. All 'LS280 and 'S280 inputs are buffered to lower the drive requirements to one Series 54LS/74LS or Series 54S/74S standard load, respectively.

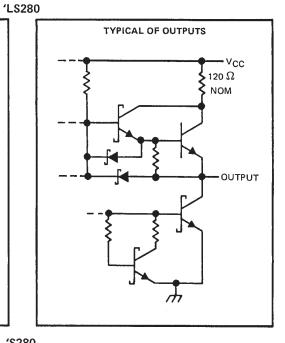


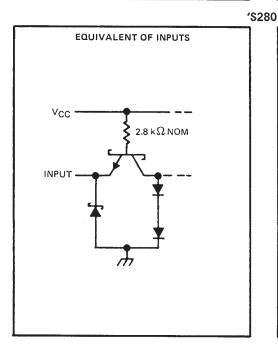
SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

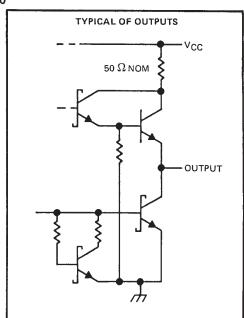
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schematics of inputs and outputs









absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage (see Note 1)	7 V
Input voltage: 'LS280	
'S280	
Operating free-air temperature range: SN54'	– 55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	
NOTE 1: Voltage values are with respect to network ground terminal.	



SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

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recommended operating conditions

		SI	SN54LS280			SN74LS280			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
V_{IH}	High-level input voltage	2	···········		2			V	
V_{IL}	Low-level input voltage			0.7			8.0	V	
Іон	High-level output current			- 0.4			- 0.4	mA	
loL	Low-level output current			4			8	mA	
T_A	Operating free-air temperature	- 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		S	N54LS2	80	SI				
.,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK	V _{CC} = MIN,	$I_1 = -18 \text{ mA}$				1.5			– 1.5	V
V _{OH}	V _{CC} = MIN, V _{IL} = MAX,	V _{IH} = 2 V, I _{OH} = - 0.4 m	A	2.5	3.4		2.7	3.4		V
VOL	V _{CC} = MIN, V _{IL} = MAX	V _{IH} = 2 V,	I _{OL} = 4 mA		0.25	0.4		0.25	0.4	V
l ₁	V _{CC} = MAX,	V ₁ = 7 V	1 92			0.1			0.1	mA
Iн	V _{CC} = MAX,	V _I = 2.7 V				20			20	μА
կլ	V _{CC} = MAX,	V _I = 0.4 V				- 0.4			- 0.4	mA
los§	V _{CC} = MAX			- 20		100	- 20		100	mA
Icc	V _{CC} = MAX,	See Note 2			16	27		16	27	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH	Data	ΣEven	C15-5 B240		33	50	
^t PHL		Inputs not under test at 0 V.		29	45	ns	
^t PLH	Data	Σ Odd	See Note 3		23	35	
tPHL	5610	2 000	See Note 3		31	50	ns

 $[\]P_{ ext{tp}_{LH}}$ \equiv propagation delay time, low-to-high-level output; $ext{tp}_{HL}$ \equiv propagation delay time, high-to-low-level output NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

NOTE 2: $I_{\mbox{\footnotesize{CC}}}$ is measured with all inputs grounded and all outputs open.

SN54LS280, SN54S280, SN74LS280, SN74S280 9-BIT ODD/EVEN PARITY GENERATORS/CHECKERS

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recommended operating conditions

	S	SN54S280			SN74S280			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Supply voltage, V _{CC}	4.5	5	5.5	4.75	5	5.25	V	
High-level output current, IOH			-1			-1	mA	
Low-level output current, IOL			20			20	mA	
Operating free-air temperature, TA	-55		125	0		70	°c	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	1	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage			2			V
VIL	Low-level input voltage				·········	0.8	V
VIK	Input clamp voltage	V _{CC} = MIN, I _I = -18 mA				-1.2	V
Vон	High-level output voltage	V _{CC} = MIN, V _{IH} = 2 V,	SN54S'	2.5	3.4		.,
, OH	Thigh tever output vortage	V _{IL} = 0.8 V, I _{OH} = -1 mA	SN74S'	2.7	3.4		\ \
VOL	Low-level output voltage	V _{CC} = MIN, V _{IH} = 2 V,				0.5	V
- 02		V _{IL} = 0.8 V, I _{OL} = 20 mA				0.5	\ \
Ц	Input current at maximum input voltage	V _{CC} = MAX, V _I = 5.5 V				1	mA
[‡] IH	High-level input current	V _{CC} = MAX, V ₁ = 2.7 V				50	μА
IL	Low-level input current	V _{CC} = MAX, V _I = 0.5 V				-2	mA
los	Short-circuit output current§	V _{CC} = MAX		-40	*	-100	mA
		VMAY SM C	N54S280		67	99	
Icc	Supply current		N74S280		67	105	mA
,,,,	ouppry current	V _{CC} = MAX, T _A = 125°C, See Note 2	N54S280N			94	mA

 $^{^\}dagger_{\perp}$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: I_{CC} is measured with all inputs grounded and all outputs open.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{PLH}	Data	Σ Even			14	21	
tPHL t	Data	2 Even	$C_L = 15 pF$, $R_L = 280 \Omega$,		11.5	18	ns
t _{PLH}	Data	Σ Odd	See Note 3		14	21	
tPHL t	Data	2 Odd			11.5	18	ns

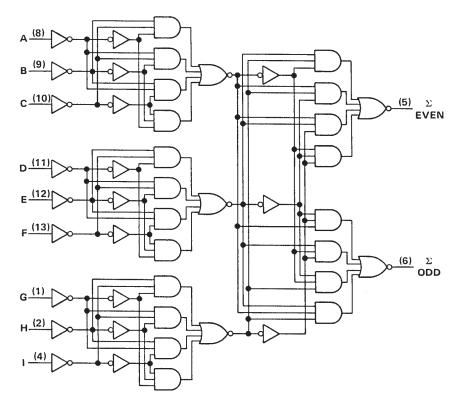
 $[\]P_{\text{tpLH}} = \text{propagation delay time, low-to-high-level output: } t_{\text{PHL}} = \text{propagation delay time, high-to-low-level output}$ NOTE 3: Load circuits and voltage waveforms are shown in Section 1.



 $[\]ddagger$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

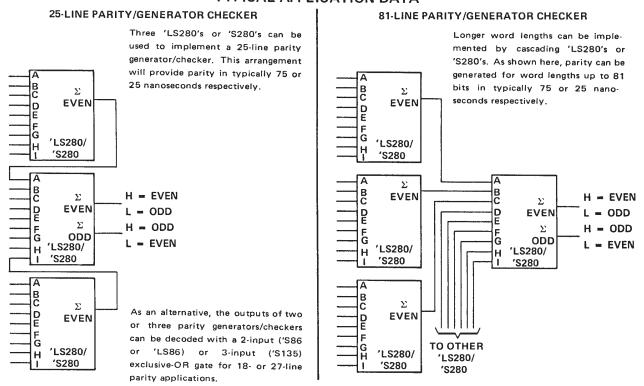
Not more than one output should be shorted at a time and duration of the short circuit should not exceed one second.

logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

TYPICAL APPLICATION DATA





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